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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/652,134	MAY ET AL.	
Examiner	Art Unit	
Daniel Pan	2183	

SEARCHED				
Class	Subclass	Date	Examiner	
712	7 224	11/20/2006	DP	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

(INCLUDING SEARCH	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR			
west pgp uspat jpoabs epoabs derwent ieee NPL ibm td 712/3, 14,15, 300 711/152, 173	11/20/2006	DP			